Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10667029	ALFERNESS ET AL.
Examiner	Art Unit
TANH Q NGUYEN	2182

SEARCHED						
Class	Subclass	Date	Examiner			
710	5,6,8,15-18,29,36,58,60,104 - limited search	03/14-15/06	TQN			
711	150,170 - limited search	03/14-15/06	TQN			
370	231,235,325,395.21,395.41,398,437,461,462,468 - limited search	03/14-15/06	TQN			

SEARCH NOTES			
Search Notes	Date	Examiner	
inventor search - East/eDAN; continuity - PALM	03/13/06	TQN	
East Search - Results attached	03/14-15/06	TQN	
Updated search - results attached; rejection maintained	09/05/06	TQN	
rejection maintained	03/01/07	TQN	
Consult SPE - re 112 rejections	03/02/07	TQN	
rejection maintained	08/15/07	TQN	
updated search - results attached	03/13-14/08	TQN	
Rejection maintained	10/18/2008	TQN	
Consult Richard Ellis re interpretation of data types - per rejection mailed 10/20/08	1/15/2009	TQN	
Consult WQAS Padmanabhan re Summary of Claimed Subject Matter - Brief is defective	8/31/2009	TQN	
OK to go the the Board with 103 rejection - per SPE Hafiz. Reevaluate 112 later.	5/10/2010	TQN	
Appeal Conference with SPE Hafiz and SPE Ellis	7/15/2010	TQN	

INTERFERENCE SEARCH		RCH	
Class	Subclass	Date	Examiner

	/T. Q. N./ Primary Examiner.Art Unit 2182
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